Search Notes			

	Application/Control No.	Applicant(s)/Patent under Reexamination
ĺ	10/661,862	NGUYEN ET AL.
	Examiner	Art Unit
	Hai L. Nguyen	2816

SEARCHED			
Class	Subclass	Date	Examiner
327	175-177, 291,293, 294,298	3/5/2005	HLN
327	144-147		
327	155,156		
327	162,165		
327	167,172	1	V
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Search	Above	3/5/2005	HLN
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
·	DATE	EXMR
Shepardize Search	3/5/2005	HLN
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